

PTO-1449 Information Disclosure Citation In an Application	Application No. 10/618,194		Applicant(s) Eva M. Sevick-Muraca, et al.
	Docket Number 017575.0700	Group Art Unit 1743	Filing Date July 11, 2003

U.S. PATENT DOCUMENTS

		DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
	A	5,818,583	10/06/1998	Sevick-Muraca et al.	356	336	11/08/1996
	B	5,865,754	02/02/1999	Sevick-Muraca et al.	600	476	08/23/1996
	C	5,917,190	06/29/1999	Yodh, et al.	250	458.1	07/25/1996
	D						
	E						
	F						
	G						
	H						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	I	WO 02/41760 A2	05/30/2002	PCT	A61B		X	
	J							
	K							

		DOCUMENT (Including Author, Title, Source, and Pertinent Pages)	DATE
	L	Reynolds et al., "Imaging of Spontaneous Canine Mammary Tumors Using Fluorescent Contrast Agents," Photochemistry and Photobiology, 1999, Vol. 70(1), pp 87-94.	
	M	Houston, et al., "Sensitivity and Depth Penetration of Continuous Wave Versus Frequency-domain Photon Migration Near-infrared Fluorescence Contrast-enhanced Imaging," Photochemistry and Photobiology, 2003, Vol. 77(4), pp 420-430.	
	N	Ntziachristos, et al. "In Vivo Tomographic Imaging of Near-Infrared Fluorescent Probes," Molecular Imaging, Vol. 1(2), April 2002, pp 82-88.	
	O	U.S. Patent Application No. 10/115,271, filed April 3, 2002, entitled "Method For Characterizing Particles in Suspension From Frequency Domain Photon Migration Measurements", currently pending (Attorney Docket No. 017575.0702)	
	P	PCT Patent Application No. PCT/US99/23709 filed October 8, 1999, entitled "Characterization of Luminescence in a Scattering Medium," currently pending (Attorney Docket No. 017575.0696)	
	Q		
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EXAMINER /Muhammad Waqas/	DATE CONSIDERED 03/27/2008
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

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